RGTVX6TS65D

650V 80A Field Stop Trench IGBT

Datasheet

V _{CES}	650V
I _{C (100°C)}	80A
V _{CE(sat) (Typ.)}	1.5V
P_D	404W

Outline TO-247N (1)(2)(3)

Features

- 1) Low Collector Emitter Saturation Voltage
- 2) High Speed Switching & Low Switching Loss
- 3) Short Circuit Withstand Time 2µs
- 4) Built in Very Fast & Soft Recovery FRD
- 5) Pb free Lead Plating; RoHS Compliant

Application

Solar Inverter

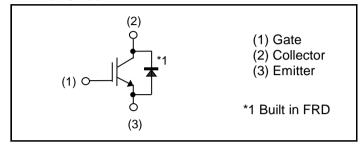
UPS

Welding

ΙH

PFC

●Inner Circuit



Packaging Specifications

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Packaging	Tube				
Reel Size (mm)	-				
Tape Width (mm)	-				
Basic Ordering Unit (pcs)	450				
Packing Code	C11				
Marking	RGTVX6TS65D				
	Packaging Reel Size (mm) Tape Width (mm) Basic Ordering Unit (pcs) Packing Code				

● Absolute Maximum Ratings (at T_C = 25°C unless otherwise specified)

Parameter		Symbol	Value	Unit	
Collector - Emitter Voltage		V _{CES}	650	V	
Gate - Emitter Voltage	Gate - Emitter Voltage		±30	V	
Calle stor Current	$T_C = 25^{\circ}C$	I _C	144	Α	
Collector Current	T _C = 100°C	I _C	80	Α	
Pulsed Collector Current	Pulsed Collector Current		320	Α	
Diode Forward Current	T _C = 25°C	I _F	127	Α	
	T _C = 100°C	I _F	80	Α	
Diode Pulsed Forward Current	ode Pulsed Forward Current		320	Α	
Power Dissipation	T _C = 25°C	P _D	404	W	
	T _C = 100°C	P _D	202	W	
Operating Junction Temperatur	Operating Junction Temperature		-40 to +175	°C	
Storage Temperature		T _{stg}	-55 to +175	°C	

^{*1} Pulse width limited by T_{jmax.}

●Thermal Resistance

Parameter	Symbol	Values			Unit
Falametei	Symbol	Min.	Тур.	Max.	Offic
Thermal Resistance IGBT Junction - Case	$R_{\theta(j-c)}$	-	-	0.37	°C/W
Thermal Resistance Diode Junction - Case	$R_{\theta(j-c)}$	-	ı	0.57	°C/W

●IGBT Electrical Characteristics (at T_j = 25°C unless otherwise specified)

Parameter	Symbol	Conditions	Values			Unit
- Farameter	Symbol	Conditions	Min.	Тур.	Max.	Offic
Collector - Emitter Breakdown Voltage	BV _{CES}	$I_{\rm C} = 10 \mu {\rm A}, {\rm V}_{\rm GE} = 0 {\rm V}$	650	ı	ı	V
Collector Cut - off Current	I _{CES}	$V_{CE} = 650V, V_{GE} = 0V$	-	-	10	μΑ
Gate - Emitter Leakage Current	I _{GES}	$V_{GE} = \pm 30V, V_{CE} = 0V$	-	-	±200	nA
Gate - Emitter Threshold Voltage	$V_{GE(th)}$	$V_{CE} = 5V, I_{C} = 57.1 \text{mA}$	5.0	6.0	7.0	V
Collector - Emitter Saturation Voltage	V _{CE(sat)}	$I_{C} = 80A, V_{GE} = 15V,$ $T_{j} = 25^{\circ}C$ $T_{j} = 175^{\circ}C$	-	1.5 1.85	1.9 -	V

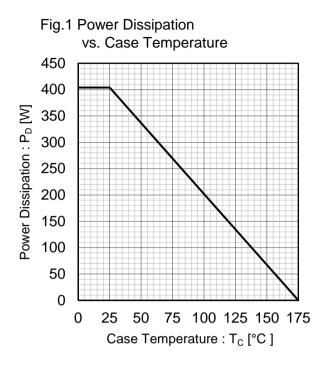
●IGBT Electrical Characteristics (at T_j = 25°C unless otherwise specified)

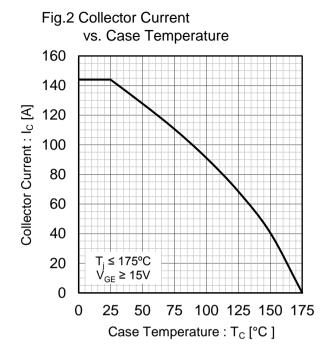
Parameter	Symbol	Conditions		Unit		
			Min.	Тур.	Max.	Offic
Input Capacitance	C _{ies}	$V_{CE} = 30V$,	-	4810	-	
Output Capacitance	C _{oes}	$V_{GE} = 0V$,	-	184	-	pF
Reverse transfer Capacitance	C _{res}	f = 1MHz	-	79	-	
Total Gate Charge	Q_g	V _{CE} = 400V,	-	171	-	
Gate - Emitter Charge	Q_{ge}	$I_{\rm C} = 80A$,	-	33	-	nC
Gate - Collector Charge	Q_{gc}	V _{GE} = 15V	-	59	-	
Turn - on Delay Time	t _{d(on)}		-	45	-	
Rise Time	t _r	$I_C = 80A, V_{CC} = 400V,$ $V_{GE} = 15V, R_G = 10\Omega,$	-	29	-	20
Turn - off Delay Time	t _{d(off)}	$T_i = 25^{\circ}C$	-	201	-	ns
Fall Time	t _f	Inductive Load	-	34	-	
Turn - on Switching Loss	E _{on}	*E _{on} include diode reverse recovery	-	2.65	-	mJ
Turn - off Switching Loss	E _{off}	Toverse recovery	-	1.80	-	
Turn - on Delay Time	t _{d(on)}	$I_C = 80A$, $V_{CC} = 400V$, $V_{GE} = 15V$, $R_G = 10\Omega$, $T_i = 175^{\circ}C$	-	49	-	ns
Rise Time	t _r		-	34	-	
Turn - off Delay Time	t _{d(off)}		-	218	-	
Fall Time	t _f	Inductive Load	-	80	-	
Turn - on Switching Loss	E _{on}	*E _{on} include diode reverse recovery	-	2.74	-	
Turn - off Switching Loss	E _{off}		-	2.31	-	mJ
Reverse Bias Safe Operating Area	RBSOA	$I_C = 320A$, $V_{CC} = 520V$, $V_P = 650V$, $V_{GE} = 15V$, $R_G = 100\Omega$, $T_j = 175^{\circ}C$	FULL SQUARE		-	
Short Circuit Withstand Time	t _{sc}	$V_{CC} \le 360V$, $V_{GE} = 15V$, $T_j = 25^{\circ}C$	2	-	-	μs

•FRD Electrical Characteristics (at $T_j = 25$ °C unless otherwise specified)

Parameter	Symbol	Conditions	Values			Unit
Parameter	Symbol		Min.	Тур.	Max.	Offic
Die de Fernand Vellere	$I_F = 80A$,			4.45	4.0	
Diode Forward Voltage	V _F	$T_j = 25^{\circ}C$ $T_j = 175^{\circ}C$	-	1.45 1.55	1.9 -	V
Diode Reverse Recovery Time	t _{rr}		-	109	-	ns
Diode Peak Reverse Recovery Current	I _{rr}	$I_F = 80A,$ $V_{CC} = 400V,$	-	12.8	-	А
Diode Reverse Recovery Charge	Q _{rr}	di _F /dt = 200A/μs, Τ _j = 25°C	ı	0.79	-	μC
Diode Reverse Recovery Energy	E _{rr}		ı	30.0	-	μJ
Diode Reverse Recovery Time	t _{rr}	$I_F = 80A,$ $V_{CC} = 400V,$ $di_F/dt = 200A/\mu s,$ $T_j = 175^{\circ}C$	ı	204	-	ns
Diode Peak Reverse Recovery Current	I _{rr}		-	18.2	-	А
Diode Reverse Recovery Charge	Q _{rr}		-	2.22	-	μC
Diode Reverse Recovery Energy	E _{rr}		-	119.3	-	μJ

• Electrical Characteristic Curves





Collector To Emitter Voltage: V_{CE} [V]

Fig.3 Forward Bias Safe Operating Area

400 350 Collector Current : Ic [A] 300 250 200 150 100 50 T_i ≤ 175°C V_{GF} = 15V 0 200 400 600 800 Collector To Emitter Voltage: V_{CE} [V]

Fig.4 Reverse Bias Safe Operating Area

•Electrical Characteristic Curves

Fig.5 Typical Output Characteristics

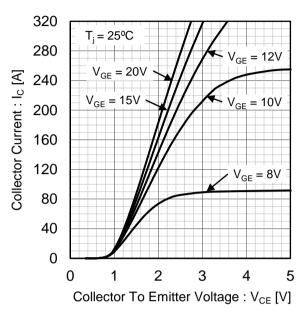


Fig.6 Typical Output Characteristics

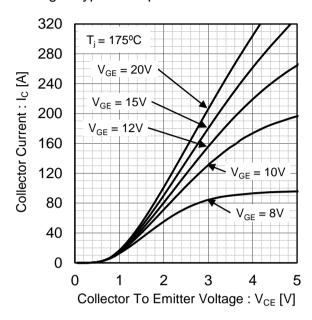


Fig.7 Typical Transfer Characteristics

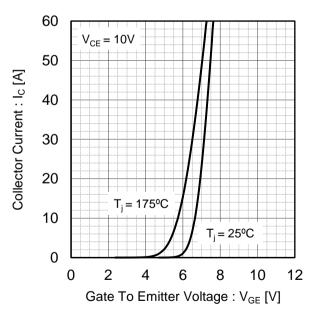
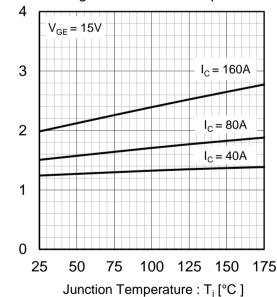


Fig.8 Typical Collector to Emitter Saturation Voltage vs. Junction Temperature



ROHM

Collector To Emitter Saturation

Voltage: V_{CE(sat)} [V]

Electrical Characteristic Curves

Fig.9 Typical Collector to Emitter Saturation
Voltage vs. Gate to Emitter Voltage

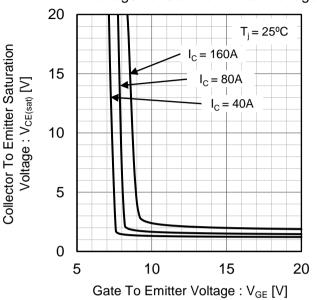


Fig.10 Typical Collector to Emitter Saturation Voltage vs. Gate to Emitter Voltage

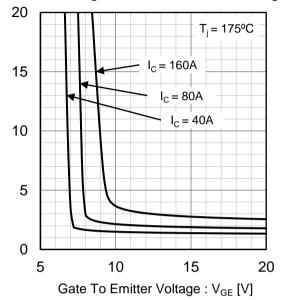


Fig.11 Typical Switching Time vs. Collector Current

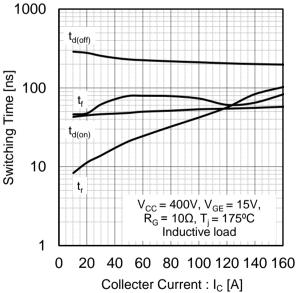
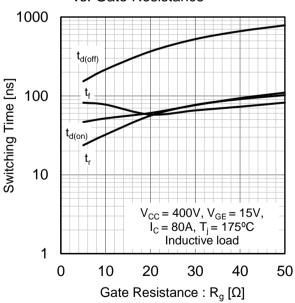


Fig.12 Typical Switching Time vs. Gate Resistance



Collector To Emitter Saturation

Voltage: V_{CE(sat)} [V]

• Electrical Characteristic Curves

20

40

60 80 100 120 140 160

Collecter Current : I_C [A]

Fig.13 Typical Switching Energy Losses vs. Collector Current

10 E_{off} E_{on} $V_{CC} = 400V, V_{GE} = 15V, R_G = 10\Omega, T_j = 175^{\circ}C$ Inductive load

0.01

Fig.14 Typocal Switching Energy Losses vs. Gate Resistance

10 E_{off} $V_{cc} = 400V, I_{c} = 80A, V_{GE} = 15V, T_{j} = 175^{\circ}C$ Inductive load

0.01

0 10 20 30 40 50

Gate Resistance : R_{G} [Ω]

Fig.15 Typical Capacitance vs. Collector to Emitter Voltage 10000 Cies 1000 Capacitance [pF] C_{oes} 100 $\mathsf{C}_{\mathsf{res}}$ 10 f = 1MHz $V_{GE} = 0V$ $T_i = 25^{\circ}C$ 0.01 0.1 10 100 Collector To Emitter Voltage: V_{CE} [V]

Fig.16 Typical Gate Charge

15

| Variable |

Electrical Characteristic Curves

0.5

0

1

1.5

Forward Voltage: V_F [V]

2

2.5

3

vs. Forward Voltage 320 280 Forward Current: IF [A] 240 200 160 $T_i = 25^{\circ}C$ 120 $T_i = 175^{\circ}C$ 80 40 0

Fig.17 Typical Diode Forward Current

vs. Forward Current 400 Reverse Recovery Time : t_{rr} [ns] 300 $T_i = 175^{\circ}C$ 200 100 $V_{CC} = 400V$ di_F/dt = 200A/µs $T_i = 25^{\circ}C$ Inductive load

0

0

20

40

Fig.18 Typical Diode Revese Recovery Time

Fig.19 Typical Diode Reverse Recovery Current vs. Forward Current

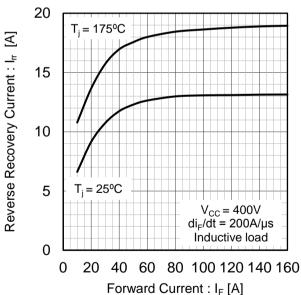
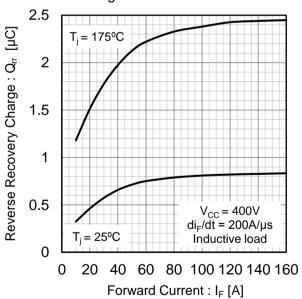


Fig.20 Typical Diode Rrverse Recovery Charge vs. Forward Current

Forward Current : I_F [A]

60 80 100 120 140 160



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• Electrical Characteristic Curves

Fig.21 Typical IGBT Transient Thermal Impedance

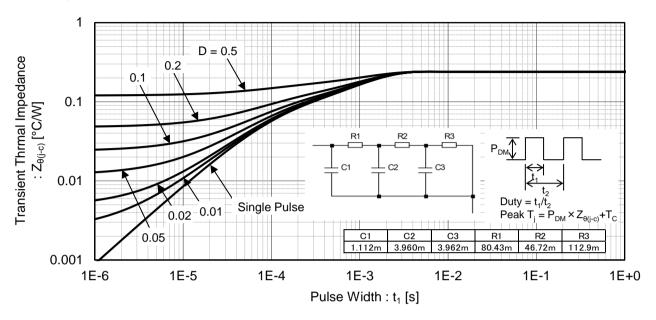
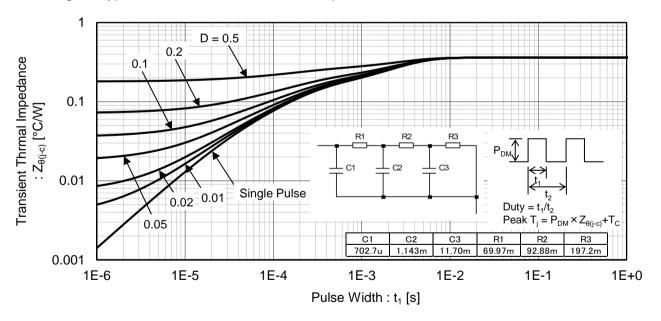


Fig.22 Typical Diode Transient Thermal Impedance



●Inductive Load Switching Circuit and Waveform

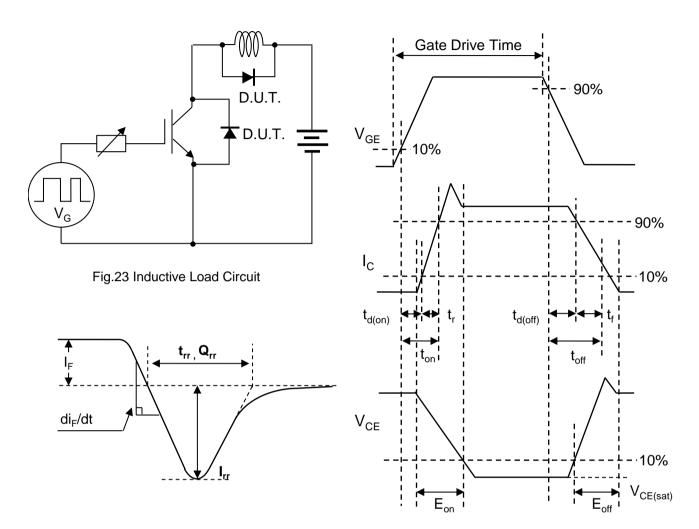


Fig.25 Diode Reverse Recovery Waveform

Fig.24 Inductive Load Waveform

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